

Search Notes

Application/Control No.

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Examiner

Hemant Patel

Applicant(s)/Patent under
Reexamination

CHANG, HISAO M.

Art Unit

2645

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB	12/22/2005	HSP
Text search only, see attached history	12/22/2005	HSP